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	Application No.	Applicant(s)
Notice of Allowability	 1.0/632,111	SEZERMAN ET AL.
	Examiner	Art Unit
	Leo Boutsikaris	2872
The MAILING DATE of this communication appeal claims being allowable, PROSECUTION ON THE MERITS IS therewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIP	(OR REMAINS) CLOSED in this app or other appropriate communication IGHTS. This application is subject to	olication. If not included will be mailed in due course. THIS
1. This communication is responsive to <u>RCE filed on 2/1/06.</u>		·
2. X The allowed claim(s) is/are <u>1-9,11-36,53,54 and 58-60</u> .		
3.		
 DEPOSIT OF and/or INFORMATION about the depo attached Examiner's comment regarding REQUIREMENT 		
A Maahman(a)	·	
Attachment(s) 1. ☑ Notice of References Cited (PTO-892)	5. Notice of Informal P	atent Application (PTO-152)
2. Notice of Draftperson's Patent Drawing Review (PTO-948)	6. Interview Summary	(PTO-413),
 Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date 	Paper No./Mail Dat 98), 7. ☐ Examiner's Amendr	e nent/Comment
Examiner's Comment Regarding Requirement for Deposit of Biological Material		ent of Reasons for Allowance
	9.	

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DETAILED ACTION

Continued Examination Under 37 CFR 1.114

A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on 2/1/2006 has been entered.

Allowable Subject Matter

Claims 1-9, 11-36, 53-54, 58-60 are allowed.

Claims 1-9, 11-36, 53-54, 58-60 are allowable over the prior art of record for at least the reason that even though the prior art discloses a method of creating a zone of permanently altered refractive index characteristics inside a planar optical waveguide by focusing a femtosecond pulsed laser inside the waveguide in an area that covers the core of the waveguide as well as a portion of the cladding, the prior art fails to teach or reasonably suggest, regarding claims 1-9, 11-36, 53-54, 58, a method for creating an optical waveguiding device from an elongated generally optical fiber having at least one core and at least one cladding, wherein the optical waveguiding device exhibits controlled polarization sensitivity, and regarding claims 59-60, a method of creating an optical waveguiding device from an elongated generally annular optical fiber having at least one core and at least one cladding by creating a zone of permanently altered

refractive index characteristics in the optical fiber, including the step of initially applying mechanical stress or an electric field to the optical fiber and then removing the mechanical stress or the electric field once the zone has been created, as set forth by the claimed combination.

Dugan (US 6,768,850, Fig. 12) discloses a method for creating altered refractive index zones inside a planar waveguide by using ultrashort laser pulses, wherein in one embodiment, the affected region extends through the cladding of the waveguide at an acute angle. However, Dugan does not teach or suggest that the structure exhibits controlled polarization sensitivity. In fact, Dugan is only concerned with changing the refractive index profile of the waveguide along the longitudinal axis and not creating a waveguiding structure that has controlled polarization sensitivity, in contrast to the claimed invention where the waveguiding structure exhibits controlled polarization sensitivity, and as such, it can be used in conjunction with commercial optical fibers as an optical tap. Davis (Optics Letters article), Nolte (SPIE Proceedings article) and Qiu (SPIE Proceedings article) all disclose methods for creating waveguiding structures inside various types of glass using femtosecond laser pulses.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Dr. Leo Boutsikaris whose telephone number is 571-272-2308.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR

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system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR

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system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Leo Boutsikaris, Ph.D., J.D.

Primary Patent Examiner, AU 2872

April 2, 2006

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PRIMARY EXAMINER